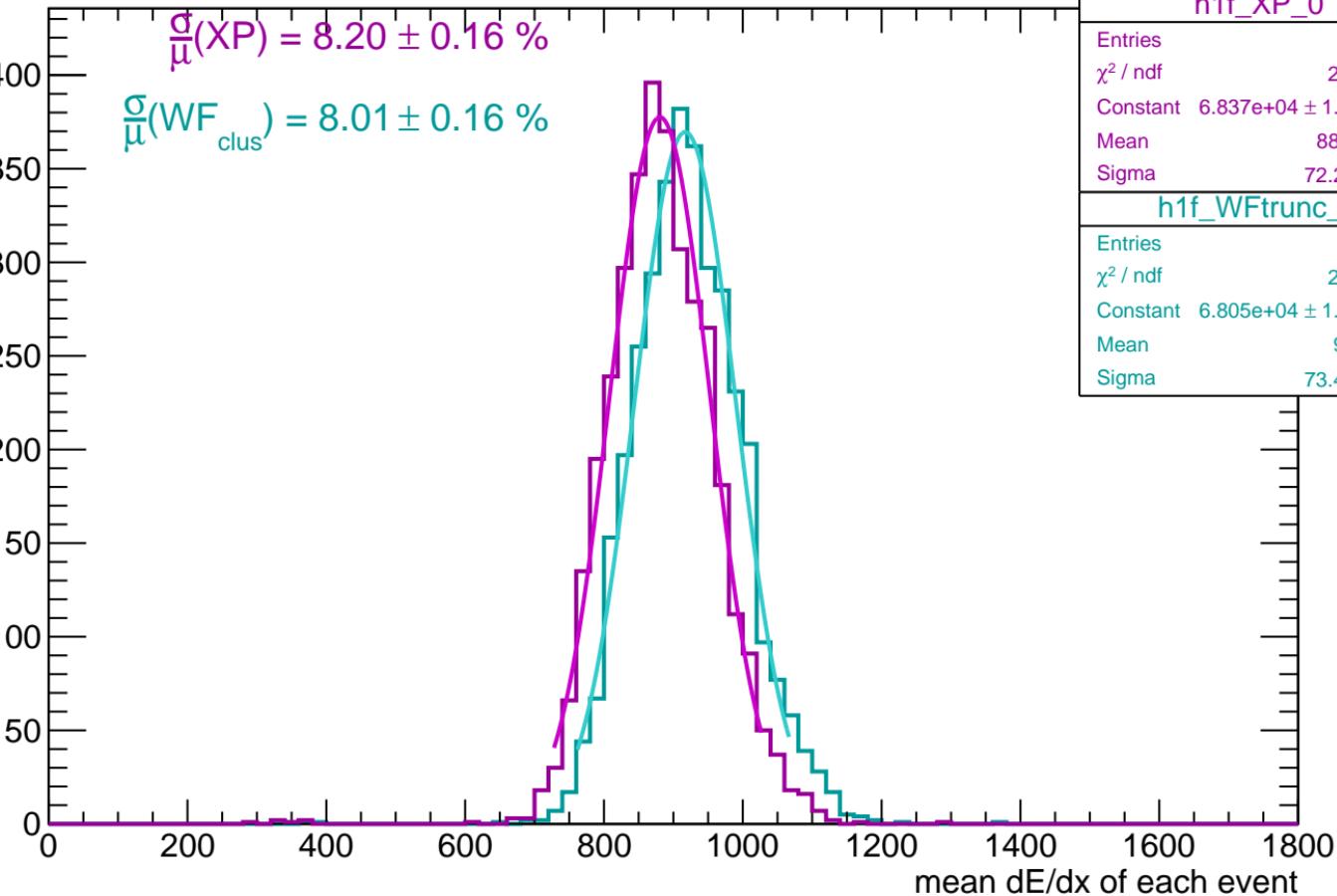Mean dE/dx with electron_ym40

$\frac{\sigma}{\mu}(XP) = 8.20 \pm 0.16$ %

$\frac{\sigma}{\mu}(WF_{clus}) = 8.01 \pm 0.16$ %

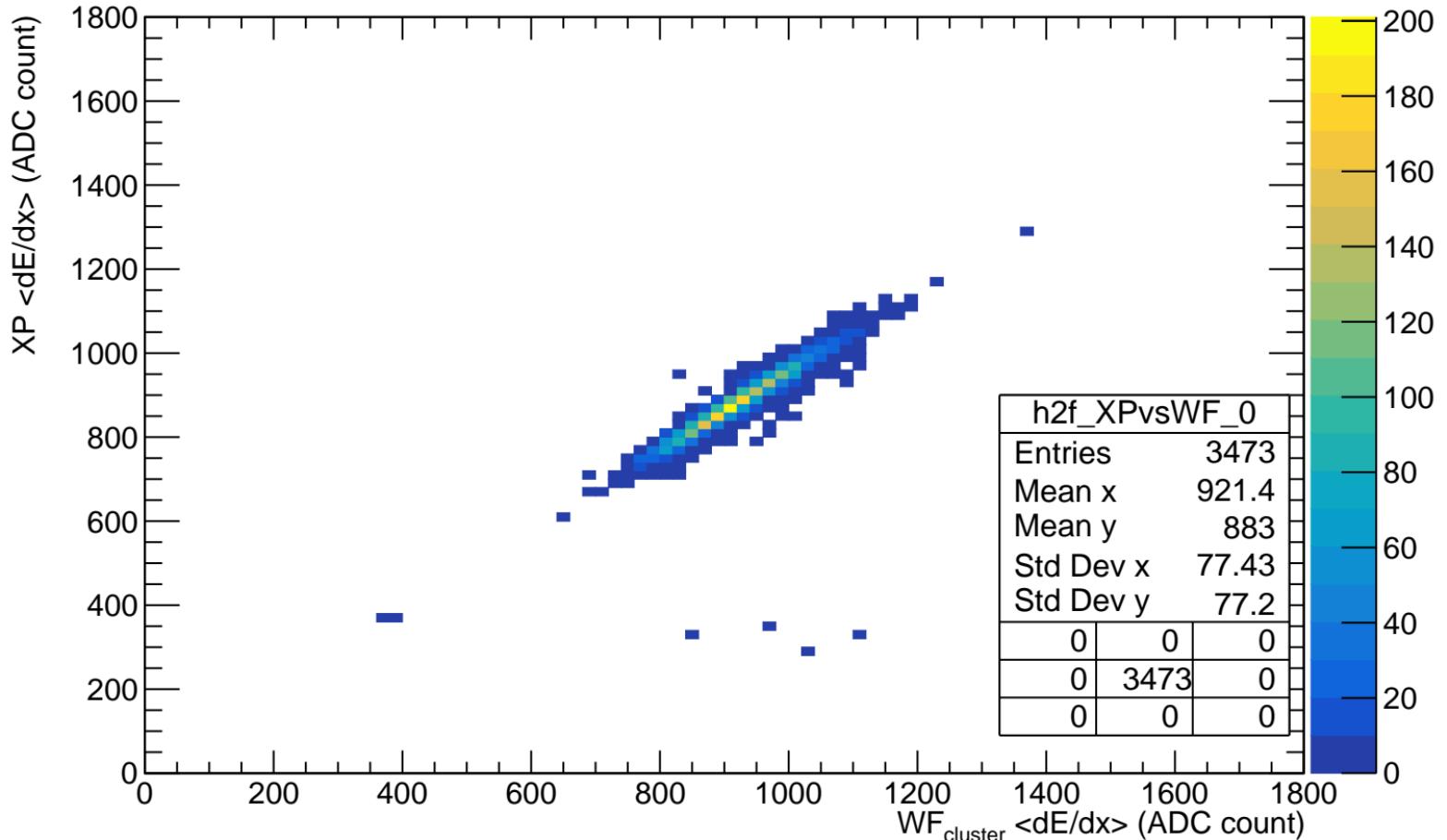| h1f_XP_0 | |
|---|---|
| Entries | 3473 |
| $\chi^2$ / ndf | 25.83 / 12 |
| Constant | 6.837e+04 ± 1.221e+03 |
| Mean | 880.6 ± 1.5 |
| Sigma | 72.24 ± 1.28 |

| h1f_WFtrunc_0 | |
|---|---|
| Entries | 3473 |
| $\chi^2$ / ndf | 25.48 / 12 |
| Constant | 6.805e+04 ± 1.221e+03 |
| Mean | 917 ± 1.5 |
| Sigma | 73.44 ± 1.34 |

mean dE/dx of each event

Counts

XP vs WF$_{cluster}$ <dE/dx> (selected data, module 0)

| h2f_XPvsWF_0 | |
|---|---|
| Entries | 3473 |
| Mean x | 921.4 |
| Mean y | 883 |
| Std Dev x | 77.43 |
| Std Dev y | 77.2 |

| 0 | 0 | 0 |
|---|---|---|
| 0 | 3473 | 0 |
| 0 | 0 | 0 |

WF$_{not\ trunc}$ - WF$_{trunc}$ vs WF$_{not\ trunc}$ (module 0)

| h2f_WFmWFvsWF_0 | | |
|---|---|---|
| Entries | | 3473 |
| Mean x | | 0 |
| Mean y | | 0 |
| Std Dev x | | 0 |
| Std Dev y | | 0 |
| 0 | 0 | 0 |
| 0 | 0 | 0 |
| 0 | 3473 | 0 |

WF$_{not\ trunc}$ <dE/dx> (ADC count)

WF$_{not\ trunc}$ - WF$_{trunc}$ <dE/dx> (ADC count)